

Search Notes

Application/Control No.

10/664,740

Examiner

Maikhanh Nguyen

Applicant(s)/Patent under
Reexamination

YALOVSKY ET AL.

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	530	2/14/2006	MK
715	526	2/14/2006	MK
709	219,229	2/14/2006	MK
Updated	Search	10/6/2006	MK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search	2/14/2006	
West Search (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	2/14/2006	MK
West Updated	10/6/2006	MK